

Embedded Flash Memory

RAW NAND MANAGED NAND





History and Mission	3 – 8
Embedded Flash Memory	6 – 1 ⁻
RAW NAND	7 – 9
Managed NAND	10 – 1
KIOXIA Automotive Solutions	10
Product List	14 –15

Leading Supplier and Inventor of Flash Memory

Silica wafers are formed from highly pure, nearly defect-free single crystalline material: the starting point for any integrated circuits

INNOVATION IS OUR TRADITION

In 1984 Toshiba invented a new type of semiconductor memory called flash memory. Later in 1987, NAND flash memory was developed that raised electronic equipment to the next level. The NAND flash market has grown rapidly, with flash memory becoming an internationally standardised memory device. KIOXIA, the inventor of flash memory, has thus carved out a path to a new era in which innovations are increased by the opportunities of NAND flash.

Under its new name, KIOXIA keeps this invention and continues to provide embedded memory solutions. Embedded memory connects us with the things that surround and serve us – for more efficiency, comfort and sustainability.

SPEED UP DIGITAL PROCESSES

Storing and processing data has always been an important aspect of all digital processes. But in the last years it increased to one of the key technologies for industry 4.0, smart mobility, cloud technology and artificial intelligence, because smart ideas and innovations have to be ready for markets right away – with high reliability of storage components.

With our embedded memory solutions, KIOXIA is the partner for all smart markets and fast moving industries. KIOXIA provides a highly grade of innovation combined with highly reliable security – now and in the future.

PARTNERSHIP IS OUR PASSION

Our success is based on our strong customer focus: Your metrics are our metrics. The result is a broad range of industry-leading flash-based storage solutions. Our products are designed to meet your specific engineering demands.

KIOXIA
EMBEDDED MEMORY –
THE KEY TO A
SMART FUTURE

"With progressive memory technology at the core, we offer products, services, and systems that create choice and define the future."

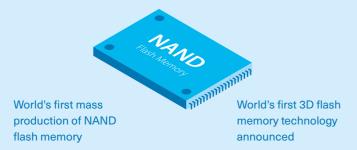




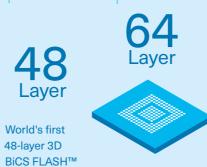
KIOXIA's Milestones



flash memory



World's first 15nm 128 Gbit NAND flash memory



96 Layer

Mass production of 96-layer BiCS FLASH™ 112 Laver

By 2020, 60 % of all enterprises will have organisation-wide digital transformation platform strategies

NEW NAME: KIOXIA Europe GmbH





















2019

2020

2021) (202

Invention of the world's first NAND flash memory

Key milestones for investment and development of KIOXIA Flash Technology World's first 24nm SLC NAND flash memory



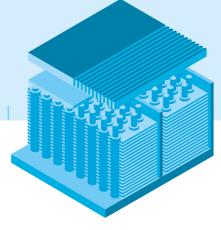
By the end of 2019, digital transformation spending is expected to reach \$1.7T, up 42 % from 2017*

By 2021, at least 50 % of global GDP will be digitised with growth driven by digitally enhanced offerings, operations and relationships*



From the invention of flash memory in 1984 to today's breakthrough BiCS FLASH™ 3D technology, KIOXIA continues to move the industry forward. Whatever the digital future demands, we will keep developing the right solutions for our customers.





1 zettabyte (ZB)

= 10²¹ bytes

= 1 billion terabytes (TB)

163 102 ZD ZB

Demanding Change

The economy's digital transformation is resulting in a massive increase of data processing, storage and traffic.

40 ZB

2019

2020

2021

2022

2023

2024

2025

*Source: IDC's Data Age 2025 study, sponsored by Seagate, April 2017

Embedded Flash Memory

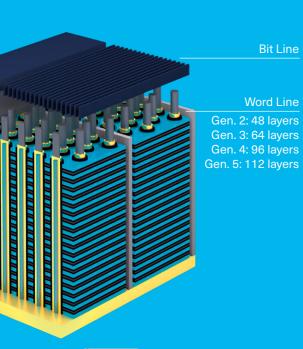
SLC NAND BENAND™ Serial NAND

e-MMC UFS

KIOXIA 3D-Technology BiCS FLASH™

Bit Line

Word Line



KIOXIA offers a wide range of advanced Flash Memory technology for all kind of applications like consumer electronics, mobile technology and industrial applications such as robotics.

NAND Flash Memory requires an appropriate management, which has to cover tasks like Bad Block Management, Wear Leveling, Garbage Collection and ECC Error Correction. Either these functions are supported by the host system in combination with raw NAND Memory, or it is covered instantly inside a managed NAND by utilizing an integrated memory controller.

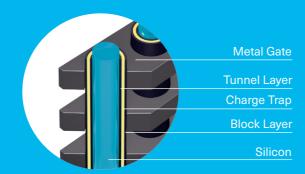
The selection between these basic different approaches to control a NAND memory defines the individual host requirements and interface options. For managed NAND there are JEDEC specified Standard-Interfaces supported, enabling the developer to easily design the required memory solution.

RAW NAND

With raw NANDs like SLC NAND, BENAND™ and Serial NAND we provide high endurance and data retention for sensitive or frequently used data.

MANAGED NAND

For efficient and easy to integrate storage systems, managed NAND like e-MMC and UFS are the preferred solutions. Offering broadly accepted standard interfaces and packages, in combination with high speed interfaces, they are the optimal selection for many application in the industrial, mobile and automotive



Our BiCS FLASH™ technology with 64-, 96- and 112-layer stacking make a powerful memory solutions possible. It gives BiCS FLASH™ far higher die area density compared to 2D NAND. BiCS FLASH™ reduces the chip size by optimizing both circuit technology and the manufacturing process.

As a result, this technology can achieve similar reliability as 2D MLC (2bit/cell) while utilizing 3D TLC (3bit/cell) structure.



SLC NAND

Reliability and Performance

KIOXIA's advanced Flash Memory technology offers SLC NAND providing best in class endurance and data retention for sensitive or frequently used data in a system. For long lasting products or systems working with extremely high data throughput between the host and the memory, KIOXIA SLC is the optimal solution.

SPECIFICATIONS

FEATURES	SLC NAND
Density	1 Gbit – 128 Gbit
Technology	24nm
ECC (Error Correction Code)	Required on Host Side
Temperature	-40°C to 85°C 0°C to 70°C
Package	TSOP and BGA

CAPACITIES:

















KEY FEATURES:

- 1 Gbit 128 Gbit
- Extended temperature range
- TSOP and BGA package

ADVANTAGES

- · Broad line up to cover customers' demands for different densities
- 24nm technology for cost optimisation
- · Long data retention or high write/ erase performance
- Small package variation available to reduce board space by 48 % (up to 8 Gbit)

APPLICATIONS:

- · Industrial Applications
- · Consumer Electronics
- · Multimedia Applications
- · Smart Metering & Intelligent Lighting
- Smart Applications







BENANDTM

80

SLC NAND with embedded ECC

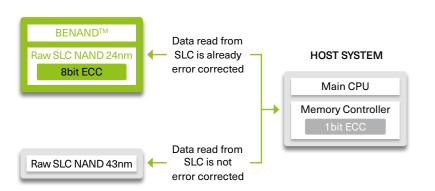
BENAND™ (Built-in ECC NAND) is a SLC NAND memory device which has an internal hardware ECC engine.

Using BENAND™ it is possible for customers to use the 24nm SLC NAND flash memory technology even when their platform cannot support higher bit ECC.

SPECIFICATIONS

FEATURES	BENAND™ (SLC+ECC)
Density	1 Gbit – 8 Gbit
Technology	24nm
ECC (Error Correction Code)	Embedded on Memory Chip
Temperature	-40° C to 85° C 0° C to 70° C
Package	TSOP and BGA

BENAND™ – SLC WITH EMBEDDED ECC FOR BOM REDUCTION AND SYSTEM FLEXIBILITY



CAPACITIES:









KEY FEATURES:

- 1 Gbit 8 Gbit
- Compatibility of SLC NAND Interface, basic functions and command sequence follows SLC NAND.
- Same hardware interface and package as raw SLC

ADVANTAGES

- Broad line-up to cover customers' demands for different densities
- 24nm technology for cost optimisation
- Long data retention or high write/ erase performance
- Small package variation available to reduce board space by 48% (up to 8 Gbit)
- With BENAND™ no ECC operation is required on the host side

APPLICATIONS:

- Industrial Applications
- Consumer Electronics
- · Multimedia Applications
- Smart Metering & Intelligent Lighting
- Smart Applications

SERIAL NAND

KIOXIA

SERIAL NAND

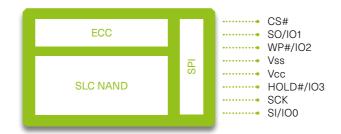
SLC NAND with Serial Peripheral Interface (SPI)

KIOXIA's new line-up of 24nm-based Serial NAND flash memory products is compatible with the widely used Serial Peripheral Interface, giving users access to SLC NAND flash memory with a low pin count, small package and large capacity.

SPECIFICATIONS

FEATURES	SERIAL NAND
Density	1 Gbit – 8 Gbit
Technology	24nm
Interface	Quad-SPI (Serial Peripheral Interface)
ECC (Error Correction Code)	Embedded on Memory Chip
Temperature	-40° C to 85° C
Package	8 pin WSON

SERIAL NAND - SLC WITH ECC AND SPI



CAPACITIES:









KEY FEATURES:

- 1 Gbit 8 Gbit
- Compatible with SPI Standard
- · Extended temperature range
- WSON package
- On-chip hardware ECC which can be turned off/on
- Unique Bit flip report function
- Data protection feature
- High speed sequential read mode
- SPI (x1, x2, x4) Mode 0, Mode 3

ADVANTAGES

- Broad line-up to cover customers' demands for different densities
- 24nm technology for cost optimization
- Long data retention or high write/ erase performance
- Small package for reduced board space
- Standardised high-speed serial interface (SPI)
- No ECC operation is required on the host side

APPLICATIONS:

- · Industrial Applications
- · Consumer Electronics
- · Multimedia Applications
- Smart Metering & Intelligent Lighting
- Smart Applications







e-MMC

Highly-efficient Storage

e-MMC is a family of advanced and highly efficient NAND flash memory with an integrated controller for enhanced memory management. Based on an interface standardised by JEDEC, KIOXIA's e-MMC offers the optimal solution for applications where higher data volumes need to be stored in an efficient way.

SPECIFICATIONS

FEATURES	e-MMC	EXTENDED TEMP. e-MMC			
Density	4 GB – 128 GB	8 GB – 64 GB			
Technology	15nm / BiCS FLASH™	15nm			
JEDEC Version	5.0 / 5.1	5.1			
Temperature	-25°C to 85°C -40°C to 105°C				
Package	153 ball FBGA (11.5 x 13 mm)				

e-MMC - NEW GENERATION WITH BICS FLASH™

Utilizing the innovative BiCS FLASH™ technology in combination with the new Charge Trap cell structure, KIOXIA introduces the best-in-class family of reliable, easy to integrate, and efficient e-MMCs. These new e-MMCs (16 to 128 GB) represent an attractive alternative with superior price competitiveness, longevity, and higher performance.

BICS FLASH

CAPACITIES:













KEY FEATURES:

- 4 GB 128 GB
- 15nm / BiCS FLASH™
- 2D-MLC / 3D-TLC technology
- e-MMC Version 5.0 and 5.1
- Integrated memory management:
- Error correction code
- Bad block management
- Wear-levelling
- Garbage collection
- Standard and extended temperature range of up to 105°C
- · FBGA package

ADVANTAGES

- Higher interface speed HS400 in accordance with JEDEC 5.x
- Managed memory
- Package, interface, features, commands, etc. are standard

APPLICATIONS:

- · Industrial Applications
- Consumer Electronics
- · Multimedia Applications
- Smart Metering & Intelligent Lighting
- Smart Applications

UFS

High Performance Storage

For applications demanding for superior interface performance, KIOXIA is offering a broad line-up of new UFS Memory products. Utilizing a full duplex serial high-speed interface, it is compliant with the latest UFS Version 2.1, 3.0 and 3.1. In combination with the embedded memory management, it offers a highly efficient and excellent performing storage solution. UFS memory with Version 3.1 enables next generation mobile devices to take full advantage of the connectivity benefits of 5G, leading to faster downloads and reduced lag time – and improved user experience.

KIOXIA

UFS

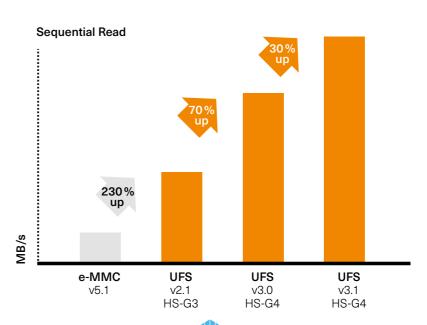
SPECIFICATIONS

FEATURES	UFS – UNIVERSAL FLASH STORAGE
Density	32 GB – 1 TB
Technology	BiCS FLASH™
JEDEC Version	2.1 / 3.0 / 3.1
Temperature	-25°C to 85°C
Package	153 ball FBGA (11.5 x 13 mm)

COMPARING THE PERFORMANCE:



FLASH MEMORY



BICS FLASH

CAPACITIES:







32 GB





KEY FEATURES:

- 32 GB 1 TB
- BiCS FLASH™
- 3D-TLC technology
- UFS Version 2.1 / 3.0 / 3.1
- · Integrated memory management:
- Error correction code
- Bad block management
- Wear-levelling
- Garbage collection
- WriteBooster (Version 3.1): Enables significantly faster write speeds
- Standard temperature range up to 85°C
- FBGA package
- High Speed Serial interface

ADVANTAGES

- High speed interface up to 1160 MB/ sec / 2320 MB/sec
- Managed memory
- Package, interface, features, commands, etc. are standard
- Utilises high quality KIOXIA BiCS FLASH™ memory in combination with a KIOXIA origin developed controller

APPLICATIONS:

- Consumer Electronics
- Multimedia Applications
- Industrial Applications
- Smart Applications





AUTOMOTIVE

Together, we move

Memory Forward

Accelerating innovation with industry-leading, flash memory technology.

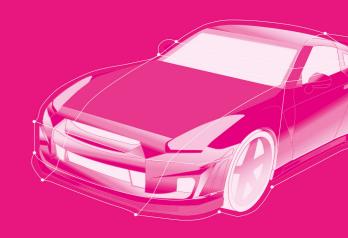




e-MMC / UFS **Automotive**

e-MMC / UFS FOR AUTOMOTIVE DEMANDS

E-mobility, autonomous driving, higher demands on safety and sustainability automotive industries are once more leading in innovation and technology. For these smart and connected vehicles, reliable storage solutions are mandatory. KIOXIA provides one of the key technologies for wireless communication, information systems and Advanced Driver Assistance Systems (ADAS).



WIRELESS COMMUNICATION

- Telematics V2X

INFORMATION

- Full-TFT Cluster
- IVI Navigation

ADAS

- · Event Data Recorder
- ADAS Route Decision
- ADAS Image Recognition

KEY FEATURES:

- AEC-Q100 qualified
- Compliant with IATF16949
- Automotive Grade 2 (-40°C ~ +105°C)
- Confirms to eMMC 5.1 and UFS 2.1
- Highly reliable technology 15nm MLC and 3D-TLC
- · Integrated memory management:
- Bad block management
- Wear-levelling
- Garbage collection
- · Automotive specific functions

e-MMC - AEC-Q100 GRADE 2

DENSITY	DENSITY PART NUMBER		POWER SUPPLY JEDEC VERSION VOLTAGE		TEMPERATURE	PACKAGE
			V _{cc} (V)	V _{ccq} (V)		
8 GB	THGBMJG6C1LBAB7	e-MMC 5.1			-40° C to 105° C	FBGA153
16 GB	THGBMJG7C2LBAB8		27.00	1.7 – 1.95		
32 GB	THGBMJG8C4LBAB8		2.7 – 3.6	2.7 – 3.6		
64 GB	THGBMJG9C8LBAB8					

Cloud Storage

UFS - AEC-Q100 GRADE 2

DENSITY	PART NUMBER	JEDEC VERSION	POWER SUPPLY N VOLTAGE		TEMPERATURE	PACKAGE
			V _{cc} (V)	V _{CCQ} (V)		
16 GB	THGAF9G7L1LBAB7				-40°C to 105°C	FBGA153
32 GB	THGAFBG8T13BAB7	UFS 2.1				
64 GB	THGAFBG9T23BAB8		2.7 – 3.6	1.7 – 1.95		
128 GB	THGAFBT0T43BAB8		2.7 - 3.0	1.7 - 1.95		
256 GB	THGAFBT1T83BAB5					
512 GB	THGAFBT2T83BABI					FBGA169



SPECIFICATIONS 14

Product List

SLC NAND

DENSITY	PART NUMBER	TECHN.	PAGE SIZE	VCC	ECC	TEMPERATURE	PACKAGE
	TC58NVG0S3HTA00		(2048+128) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58NYG0S3HBAI4		(2048+128) x 8 bit	1.8V		-40° C to 85° C	63BGA 9 x 11
1 Gbit	TC58NVG0S3HTAI0	24nm	(2048+128) x 8 bit	3.3V	8bit/512B	-40° C to 85° C	48TSOP 12 x 20
TO	TC58NVG0S3HBAI4		(2048+128) x 8 bit	3.3V	8011/5128	-40° C to 85° C	63BGA 9 x 11
	TC58NYG0S3HBAI6		(2048+128) x 8 bit	1.8V		-40° C to 85° C	67BGA 6.5 x 8
	TC58NVG0S3HBAI6		(2048+128) x 8 bit	3.3V		-40° C to 85° C	67BGA 6.5 x 8
	TC58NVG1S3HTA00		(2048+128) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58NYG1S3HBAI4		(2048+128) x 8 bit	1.8V		-40°C to 85°C	63BGA 9 x 11
2 Gbit	TC58NVG1S3HTAI0	24nm	(2048+128) x 8 bit	3.3V	8bit/512B	-40°C to 85°C	48TSOP 12 x 20
2 Gbit	TC58NVG1S3HBAI4	2411111	(2048+128) x 8 bit	3.3V	6DII/ 512D	-40°C to 85°C	63BGA 9 x 11
	TC58NYG1S3HBAI6		(2048+128) x 8 bit	1.8V		-40°C to 85°C	67BGA 6.5 x 8
	TC58NVG1S3HBAI6		(2048+128) x 8 bit	3.3V		-40°C to 85°C	67BGA 6.5 x 8
	TH58NVG2S3HTA00		(2048+128) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58NVG2S0HTA00		(4096+256) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58NVG2S0HTAI0		(4096+256) x 8 bit	3.3V	8bit/512B	-40°C to 85°C	48TSOP 12 x 20
	TH58NVG2S3HTAI0	24nm	(2048+128) x 8 bit	3.3V		-40°C to 85°C	48TSOP 12 x 20
4 Gbit	TH58NVG2S3HBAI4		(2048+128) x 8 bit	3.3V		-40°C to 85°C	63BGA 9 x 11
4 abit	TH58NYG2S3HBAI4		(2048+128) x 8 bit	1.8V		-40°C to 85°C	63BGA 9 x 11
	TC58NVG2S0HBAI4		(4096+256) x 8 bit	3.3V		-40°C to 85°C	63BGA 9 x 11
	TC58NYG2S0HBAI4		(4096+256) x 8 bit	1.8V		-40°C to 85°C	63BGA 9 x 11
	TC58NVG2S0HBAI6		(4096+256) x 8 bit	3.3V		-40°C to 85°C	67BGA 6.5 x 8
	TC58NYG2S0HBAI6		(4096+256) x 8 bit	1.8V		-40°C to 85°C	67BGA 6.5 x 8
	TH58NVG3S0HTA00		(4096+256) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TH58NVG3S0HBAI4		(4096+256) x 8 bit	3.3V		-40°C to 85°C	63BGA 9 x 11
8 Gbit	TH58NYG3S0HBAI4	24nm	(4096+256) x 8 bit	1.8V	8bit/512B	-40°C to 85°C	63BGA 9 x 11
o abit	TH58NVG3S0HTAI0	2411111	(4096+256) x 8 bit	3.3V	0010, 0120	-40° C to 85° C	48TSOP 12 x 20
	TH58NVG3S0HBAI6		(4096+256) x 8 bit	3.3V		-40° C to 85° C	67BGA 6.5 x 8
	TH58NYG3S0HBAI6		(4096+256) x 8 bit	1.8V		-40° C to 85° C	67BGA 6.5 x 8
16 Gbit	TH58NVG4S0HTA20	24nm	(4096+256) x 8 bit	3.3V	8bit/512B	0°C to 70°C	48TSOP 12 x 20
10 abit	TH58NVG4S0HTAK0	2411111	(4096+256) x 8 bit	3.3V	0017,0120	-40° C to 85° C	48TSOP 12 x 20
32 Gbit	TC58NVG5H2HTA00	24nm	(8192+1024) x 8 bit	3.3V	24bit/1024B	0°C to 70°C	48TSOP 12 x 20
JZ GDIL	TC58NVG5H2HTAI0	2411111	(8192+1024) x 8 bit	3.3V	240IU 1024D	-40° C to 85° C	48TSOP 12 x 20
64 Gbit	TH58NVG6H2HTAK0	24nm	(8192+1024) x 8 bit	3.3V	24bit/1024B	-40° C to 85° C	48TSOP 12 x 20
04 apit	TH58NVG6H2HTA20	L-111111	(8192+1024) x 8 bit	3.3V	24010 10240	0°C to 70°C	48TSOP 12 x 20
128 Gbit	TH58NVG7H2HTAK0	24nm	(8192+1024) x 8 bit	3.3V	24bit/1024B	-40° C to 85° C	48TSOP 12 x 20
120 0011	TH58NVG7H2HTA20	2411111	(8192+1024) x 8 bit	3.3V	2401(/ TOZ4D	0°C to 70°C	48TSOP 12 x 20

SERIAL NAND

DENSITY	PART NUMBER	PAGE SIZE	vcc	TEMPERATURE	PACKAGE
1 Gbit	TC58CVG0S3HRAIJ	(2049 : 64) v 9 hit	3.3V	-40° C to 85° C	8WSON 6x8
I GDIL	TC58CYG0S3HRAIJ	(2048+64) x 8 bit	1.8V	-40 C t0 65 C	
2 Gbit	TC58CVG1S3HRAIJ	(2048+64) x 8 bit	3.3V	-40° C to 85° C	8WSON 6x8
2 GDIT	TC58CYG1S3HRAIJ		1.8V		
4 Gbit	TC58CVG2S0HRAIJ	(4096+128) x 8 bit	3.3V	-40°C to 85°C	8WSON 6x8
4 GDIL	TC58CYG2S0HRAIJ		1.8V	-40 C t0 65 C	OVVOCIN UXO
0.064	TH58CVG3S0HRAIJ	(4000 · 400) · · 0 bit	3.3V	40° C += 05° C	0/4/2/01/10/2
8 Gbit	TH58CYG3S0HRAIJ	(4096+128) x 8 bit	1.8V	-40°C to 85°C	8WSON 6x8

Product List

BENAND™

DENSITY	PART NUMBER	TECHN.	PAGE SIZE	vcc	ECC	TEMPERATURE	PACKAGE
	TC58BVG0S3HTA00		(2048+64) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58BYG0S3HBAI4		(2048+64) x 8 bit	1.8V		-40°C to 85°C	63BGA 9 x 11
1 Gbit	TC58BVG0S3HTAI0	04000	(2048+64) x 8 bit	3.3V	internal ECC	-40°C to 85°C	48TSOP 12 x 20
	TC58BVG0S3HBAI4	24nm	(2048+64) x 8 bit	3.3V	internal ECC	-40°C to 85°C	63BGA 9 x 11
	TC58BYG0S3HBAI6		(2048+64) x 8 bit	1.8V		-40°C to 85°C	67BGA 6.5 x 8
	TC58BVG0S3HBAI6		(2048+64) x 8 bit	3.3V		-40°C to 85°C	67BGA 6.5 x 8
	TC58BVG1S3HTA00		(2048+64) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58BYG1S3HBAI4		(2048+64) x 8 bit	1.8V		-40°C to 85°C	63BGA 9 x 11
2 Gbit	TC58BVG1S3HTAI0	24nm	(2048+64) x 8 bit	3.3V	internal ECC	-40°C to 85°C	48TSOP 12 x 20
2 GDIL	TC58BVG1S3HBAI4	2411111	(2048+64) x 8 bit	3.3V	internal LCC	-40°C to 85°C	63BGA 9 x 11
	TC58BYG1S3HBAI6		(2048+64) x 8 bit	1.8V		-40°C to 85°C	67BGA 6.5 x 8
	TC58BVG1S3HBAI6		(2048+64) x 8 bit	3.3V		-40°C to 85°C	67BGA 6.5 x 8
	TH58BVG2S3HTA00		(2048+64) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58BVG2S0HTA00		(4096+128) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58BVG2S0HTAI0		(4096+128) x 8 bit	3.3V		-40°C to 85°C	48TSOP 12 x 20
	TH58BVG2S3HTAI0		(2048+64) x 8 bit	3.3V		-40°C to 85°C	48TSOP 12 x 20
	TH58BVG2S3HBAI4		(2048+64) x 8 bit	3.3V		-40°C to 85°C	63BGA 9 x 11
4 Gbit	TH58BYG2S3HBAI4	24nm	(2048+64) x 8 bit	1.8V	internal ECC	-40°C to 85°C	63BGA 9 x 11
	TC58BVG2S0HBAI4		(4096+128) x 8 bit	3.3V		-40°C to 85°C	63BGA 9 x 11
	TC58BYG2S0HBAI4		(4096+128) x 8 bit	1.8V		-40°C to 85°C	63BGA 9 x 11
	TC58BVG2S0HBAI6		(4096+128) x 8 bit	3.3V		-40° C to 85° C	67BGA 6.5 x 8
	TC58BYG2S0HBAI6		(4096+128) x 8 bit	1.8V		-40° C to 85° C	67BGA 6.5 x 8
	TH58BYG2S3HBAI6		(2048+64) x 8 bit	1.8V		-40° C to 85° C	67BGA 6.5 x 8
	TH58BVG3S0HTA00		(4096+128) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TH58BYG3S0HBAI4		(4096+128) x 8 bit	1.8V		-40° C to 85° C	63BGA 9 x 11
8 Gbit	TH58BVG3S0HTAI0	24nm	(4096+128) x 8 bit	3.3V	internal ECC	-40° C to 85° C	48TSOP 12 x 20
o abit	TH58BVG3S0HBAI4	2411111	(4096+128) x 8 bit	3.3V	internal LOO	-40° C to 85° C	63BGA 9 x 11
	TH58BVG3S0HBAI6		(4096+128) x 8 bit	3.3V		-40° C to 85° C	67BGA 6.5 x 8
	TH58BYG3S0HBAI6		(4096+128) x 8 bit	1.8V		-40° C to 85° C	67BGA 6.5 x 8

e-MMC

DENSITY	PART NUMBER	TECHN.	JEDEC VERSION	TEMPERATURE	PACKAGE
4 GB THGBM	THGBMNG5D1LBAIT	2D MLC	e-MMC 5.0	-25°C to 85°C	153FBGA 11 x 10
405	THGBMNG5D1BAIL	2D IVILO	6-WIWO 5.0	-25°C to 85°C	153FBGA 11.5 x 13
8 GB	THGBMJG6C1LBAIL	2D MLC	e-MMC 5.1	-25°C to 85°C	153FBGA 11.5 x 13
0 GB	THGBMJG6C1LBAU7	ZD IVILO	e-MINO 3.1	-40°C to 105°C	153FBGA 11.5 x 13
	THGBMJG7C1LBAIL	2D MLC		-25°C to 85°C	153FBGA 11.5 x 13
16 GB		2D MILC	e-MMC 5.1	-40°C to 105°C	153FBGA 11.5 x 13
			-25°C to 85°C	153FBGA 11.5 x 13	
	THGBMJG8C2LBAIL	2D MLC		-25°C to 85°C	153FBGA 11.5 x 13
32 GB	THGBMJG8C4LBAU8	2D IVILO	e-MMC 5.1	-40° C to 105° C	153FBGA 11.5 x 13
	THGAMRG8T13BAIL	3D TLC		-25°C to 85°C	153FBGA 11.5 x 13
64 GB	THGBMJG9C8LBAU8	2D MLC	e-MMC 5.1	-40° C to 105° C	153FBGA 11.5 x 13
04 GB	THGAMRG9T23BAIL		e-iviiviC 5.1	-25°C to 85°C	153FBGA 11.5 x 13
128 GB	THGAMRT0T43BAIR	3D TLC	e-MMC 5.1	-25°C to 85°C	153FBGA 11.5 x 13

UFS

DENSITY	PART NUMBER	TECHNOLOGY	JEDEC VERSION	TEMPERATURE	PACKAGE
32 GB	THGAF8G8T23BAIL	3D TLC	UFS 2.1	-25°C to 85°C	153FBGA 11.5 x 13
64 GB	THGAF8G9T43BAIR	3D TLC	UFS 2.1	-25°C to 85°C	153FBGA 11.5 x 13
128 GB	THGAF8T0T43BAIR	3D TLC	UFS 2.1	-25° C to 85° C	153FBGA 11.5 x 13
	THGJFAT0T44BAIL		UFS 3.1		
256 GB	THGAF8T1T83BAIR	3D TLC	UFS 2.1	-25° C to 85° C	153FBGA 11.5 x 13
	THGJFAT1T84BAIR		UFS 3.1		
512 GB	THGJFAT2T84BAIR	3D TLC	UFS 3.1	-25°C to 85°C	153FBGA 11.5 x 13



KIOXIA Europe GmbH Hansaallee 181 40549 Düsseldorf, Germany Further information business.kioxia.com

Copyright 10/2020 – KIOXIA Europe GmbH. Product specifications are all subject to change without notice. Errors and omissions excepted. 10/2020

Images are for illustration purpose only.

All company names, product names and service names may be trademarks of their respective companies.